


<b>Search Notes</b>  	<b>Application/Control No.</b>  10815009	<b>Applicant(s)/Patent Under Reexamination</b>  DEEPAK ET AL.
	<b>Examiner</b>  Long Pham	<b>Art Unit</b>  2814

SEARCHED			
Class	Subclass	Date	Examiner
257	666, 676, 678	11/14/09	LP

SEARCH NOTES		
Search Notes	Date	Examiner
Updated text and interference searches	11/14/09	LP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	666	11/14/09	LP

--	--